

AOSP36326C

30V N-Channel MOSFET

General Description

- Trench Power MOSFET technology
- Very Low $R_{DS(ON)}$ at 4.5V V_{GS}
- Low Gate Charge
- High Current Capability
- RoHS and Halogen-Free Compliant

Product Summary

 $\begin{array}{ll} V_{DS} & 30V \\ I_{D} \; (at \; V_{GS} \! = \! 10V) & 12A \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 10V) & < 11 m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 4.5V) & < 17 m\Omega \end{array}$

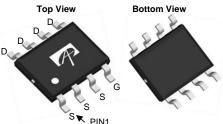
100% UIS Tested 100% Rg Tested

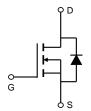


Applications

- DC/DC Converters in Computing, Servers, and POL
- Isolated DC/DC Converters in Telecom and Industrial
- See Note G







Orderable Part Number Package Type		Form	Minimum Order Quantity		
AOSP36326C	SO-8	Tape & Reel	3000		

Parameter	Symbol	Maximum	Units		
Drain-Source Voltage	V _{DS}	30	V		
Gate-Source Voltage	V_{GS}	±20	V		
Continuous Drain T _A =25°C		12			
Current T _A =70°C	I _D	9.4	А		
Pulsed Drain Current ^C	I _{DM}	48			
Avalanche Current ^C	I _{AS}	15	А		
Avalanche energy L=0.1mH ^C	E _{AS}	11	mJ		
T _A =25°C	D	2.5	W		
Power Dissipation B T _A =70°C	P_{D}	1.6	<u> </u>		
Junction and Storage Temperature Range	T _J , T _{STG}	-55 to 150	°C		

Thermal Characteristics						
Parameter		Symbol	Тур	Max	Units	
Maximum Junction-to-Ambient A	t ≤ 10s	$R_{\theta,JA}$	42	50	°C/W	
Maximum Junction-to-Ambient AD	Steady-State	IN _θ JA	70	85	°C/W	
Maximum Junction-to-Lead	Steady-State	$R_{\theta JL}$	20	30	°C/W	



Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units	
STATIC F	PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	ID=250µA, VGS=0V		30			V
ı	Zero Gate Voltage Drain Current	V_{DS} =30V, V_{GS} =0V				1	μA
I _{DSS}	Zero Gate Voltage Drain Current		T _J =55°C			5	μΛ
I _{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} =±20V				±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$		1.3	1.8	2.3	V
	Static Drain-Source On-Resistance	V_{GS} =10V, I_D =12A			9	11	mΩ
R _{DS(ON)}			T _J =125°C		12.5	15	
		V_{GS} =4.5V, I_{D} =10A			13.5	17	mΩ
g _{FS}	Forward Transconductance	V_{DS} =5V, I_D =12A			45		S
V_{SD}	Diode Forward Voltage	I _S =1A, V _{GS} =0V			0.72	1	V
I _S	Maximum Body-Diode Continuous Current					3.5	Α
DYNAMIC	PARAMETERS		-		-		
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =15V, f=1MHz			542		pF
C _{oss}	Output Capacitance				233		pF
C_{rss}	Reverse Transfer Capacitance				31		pF
R_g	Gate resistance	f=1MHz		1	2	3	Ω
SWITCHI	NG PARAMETERS		-				
Q _g (10V)	Total Gate Charge	V _{GS} =10V, V _{DS} =15V, I _D =12A			9	15	nC
Q _g (4.5V)	Total Gate Charge				4.3	7	nC
Q_{gs}	Gate Source Charge				2.2		nC
Q_{gd}	Gate Drain Charge				1.7		nC
t _{D(on)}	Turn-On DelayTime	V_{GS} =10V, V_{DS} =15V, R_{L} =1.25 Ω , R_{GEN} =3 Ω			4		ns
t _r	Turn-On Rise Time				3.5		ns
t _{D(off)}	Turn-Off DelayTime				18		ns
t _f	Turn-Off Fall Time				3		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =12A, di/dt=500A/μs			9.7		ns
Q_{rr}	Body Diode Reverse Recovery Charge	I _F =12A, di/dt=500A/μs			11.5		nC

A. The value of R_{0JA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The

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A. The value in any given application depends on the user's specific board design.

B. The power dissipation P_D is based on T_{J(MAX)}=150° C, using ≤ 10s junction-to-ambient thermal resistance.

C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150° C. Ratings are based on low frequency and duty cycles to keep initialT_J=25° C.

D. The R_{0JA} is the sum of the thermal impedance from junction to lead R_{0JL} and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

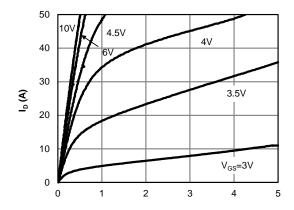
F. These curves are based on the junction-to-ambient thermal impedance which is measured with the device mounted on 1ir² FR-4 board with

²oz. Copper, assuming a maximum junction temperature of T_{J(MAX)}=150° C. The SOA curve provides a single pulse rating.

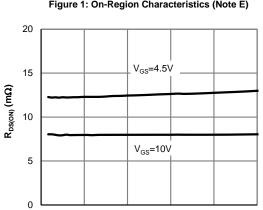
G. For application requiring slow >1ms turn-on/turn-off, please consult AOS FAE for proper product selection.



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



V_{DS} (Volts)
Figure 1: On-Region Characteristics (Note E)



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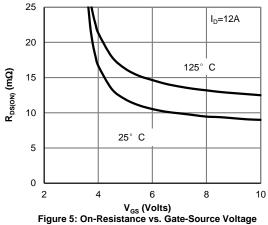
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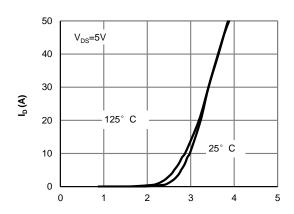
 $\label{eq:local_local} \mathbf{I_{D}}\left(\mathbf{A}\right)$ Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

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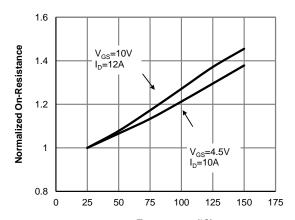
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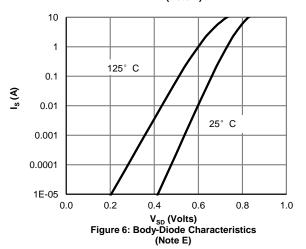
(Note E)



V_{GS} (Volts) Figure 2: Transfer Characteristics (Note E)



Temperature (°C)
Figure 4: On-Resistance vs. Junction Temperature
(Note E)



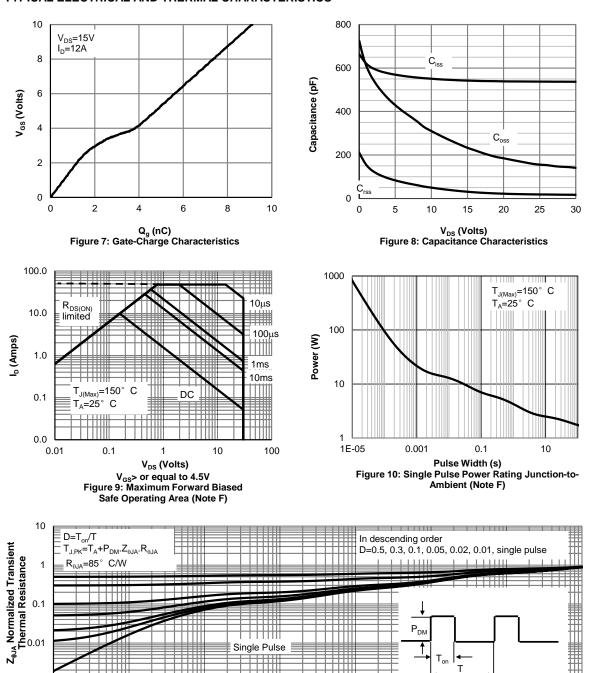


0.001 L 1E-05

0.0001

0.001

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

0.1

10

100

0.01

Charge

Figure A: Gate Charge Test Circuit & Waveforms

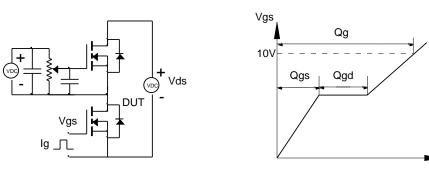


Figure B: Resistive Switching Test Circuit & Waveforms

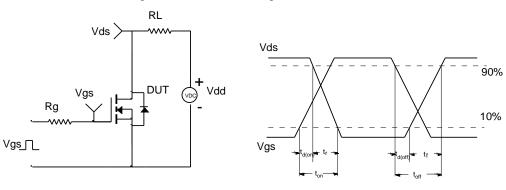


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

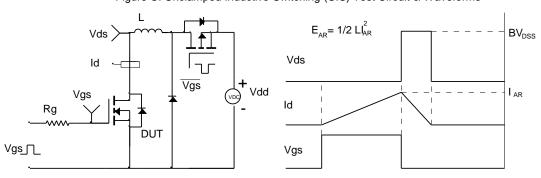
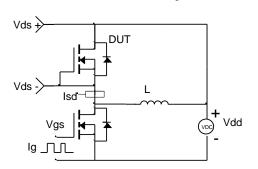
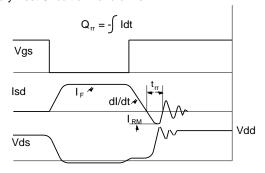


Figure D: Diode Recovery Test Circuit & Waveforms





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